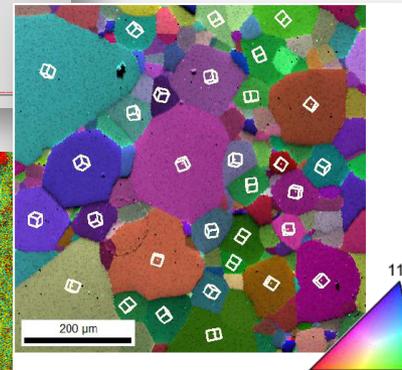
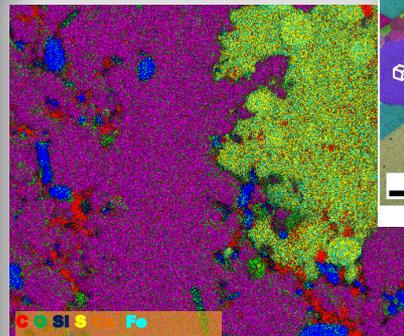
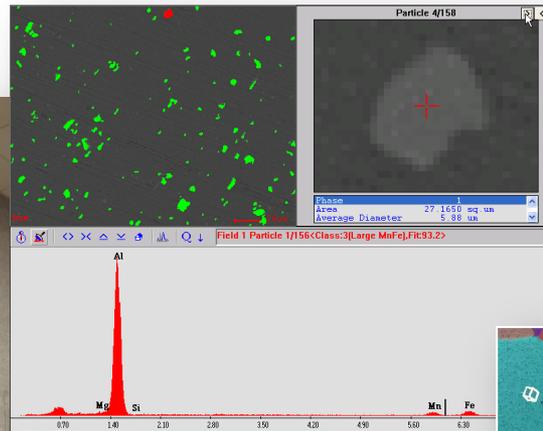
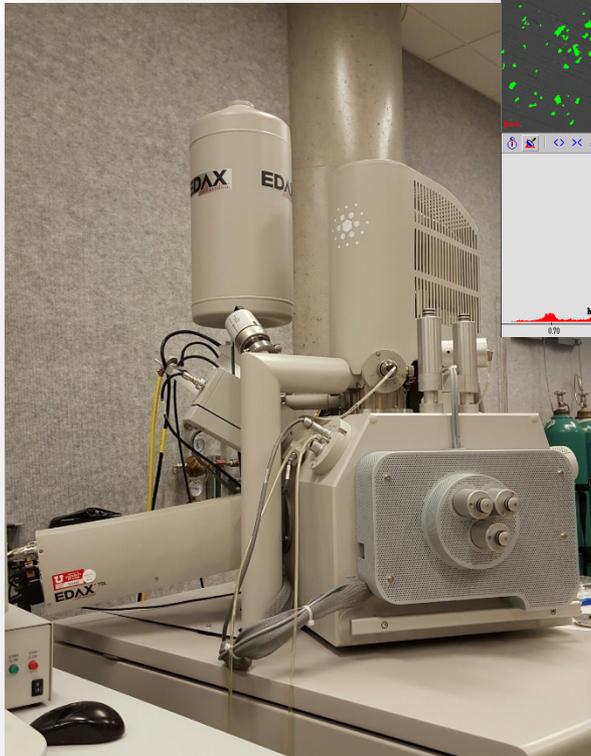


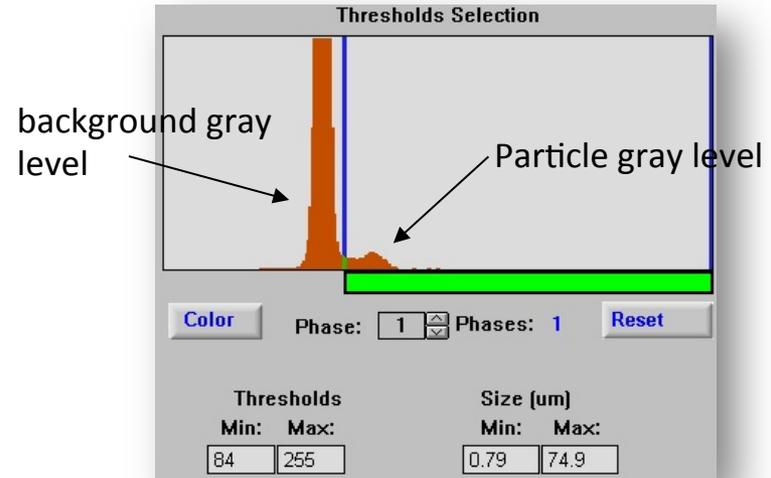
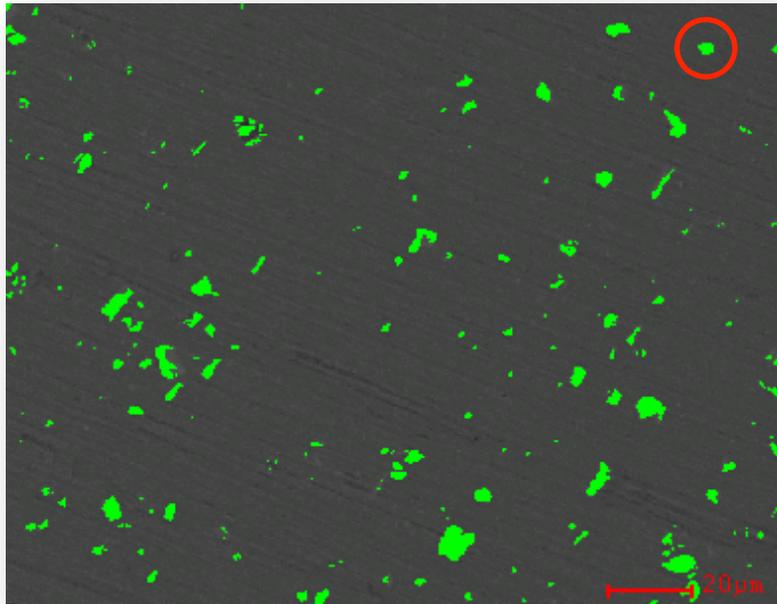
EDAX Particle Phase Analysis:

A New SEM Capability for Automated Elemental and Morphological Analysis of Dispersed Particles and Precipitates

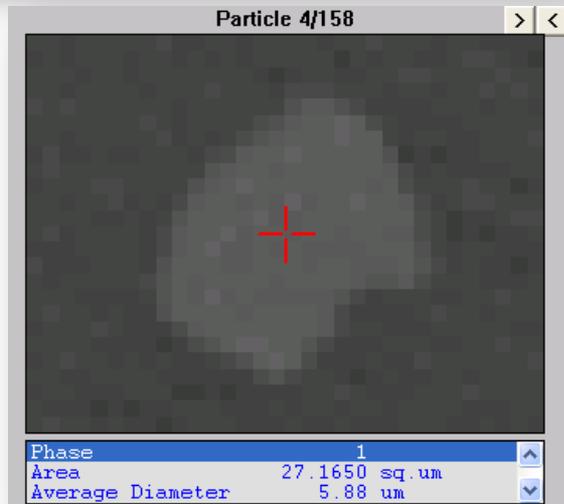
Paulo Perez
Surface Scientist
Surface Analysis Lab



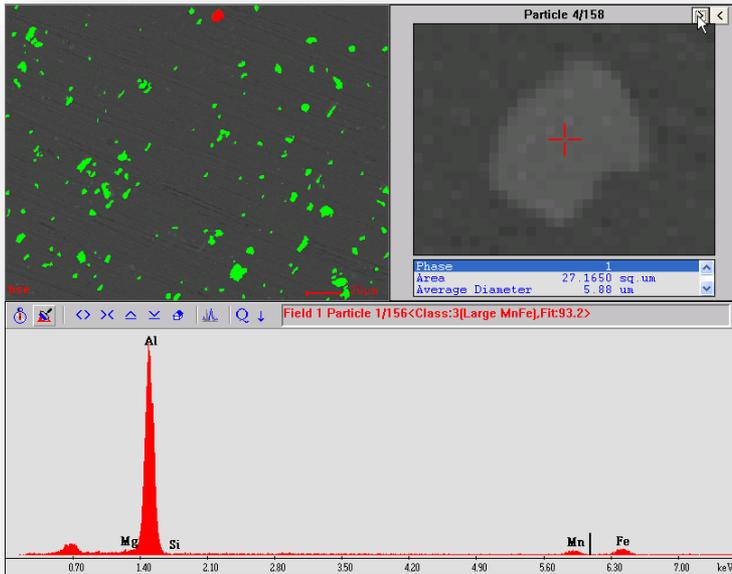
Morphology Analysis



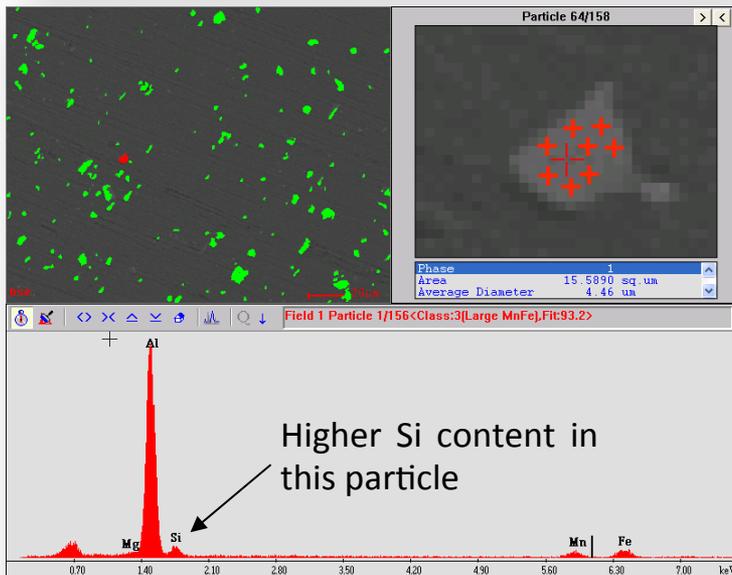
- Particles are identified from the matrix based on image contrast from a BSE image
- Size, shape, and morphology of each individual particle in the field of view is characterized by the image processing software based on the number of pixels contained by a particle
 - Area
 - Diameter
 - Perimeter
 - Orientation
 - Aspect ratio
 - Shape (roundness)



Elemental Analysis



Allows classification of each particle into different groups based on its elemental components



C:\EDAXProjects\AlumCan\lib1.cls

| | | |
|-----------------|--------|---------|
| 1 Part1 | Insert | Replace |
| 2 Part2 | Delete | Del All |
| Add Pass Filter | | |

Part2 Type ZAF Elem Wt%

| | | | | |
|-----------|---------------------------------------|------|--------------|----------------|
| MgK 1.62 | MgK | 1.62 | ZAF Elem Wt% | Classify |
| AlK 78.45 | | | | |
| SiK 0.00 | | | | |
| MnK 9.37 | <input type="checkbox"/> Class Filter | Min | 0.0 | Min Fit % 50.0 |
| FeK 10.57 | | Max | 100.0 | Cls 1: 81.5% |
| | <input type="checkbox"/> Pre Scan | | | |

Elemental Analysis

C:\PART\USR\9Fields\stub01\stub01.c

2 Ca Px
3 Mg Px
4 Garnet
5 Rutile

Garnet Type

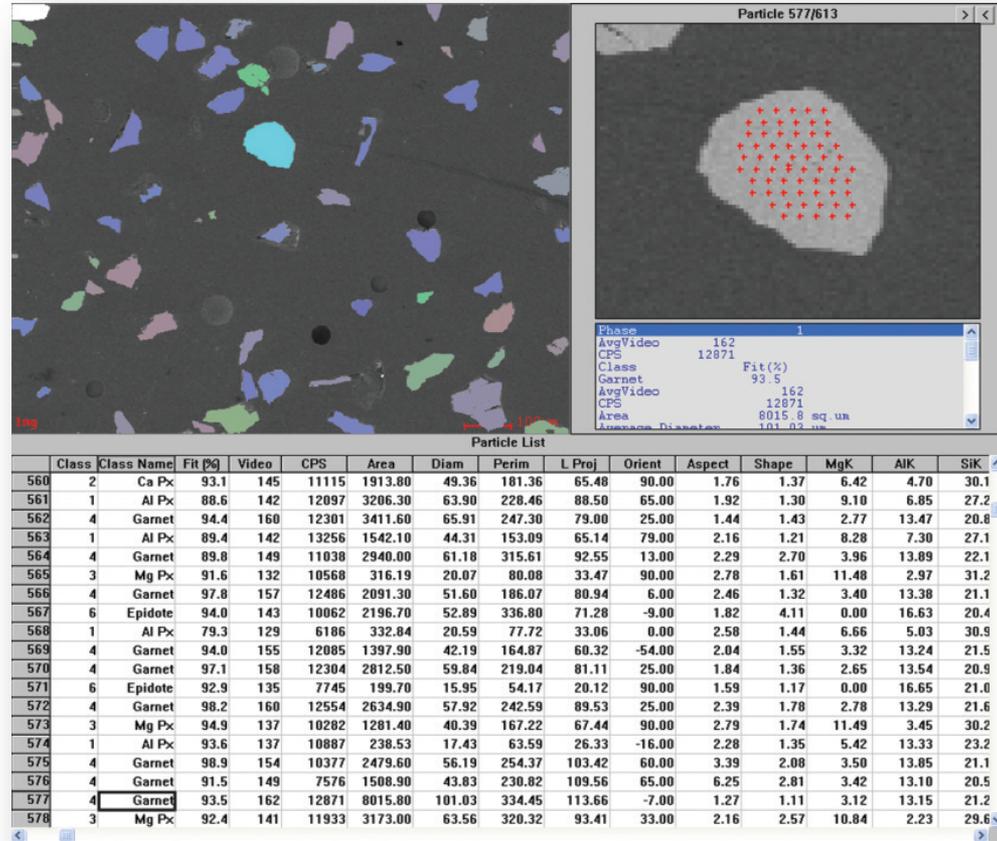
OK 33.43
NaK 0.00
MgK 3.16
AlK 13.81
SiK 21.63
PK 0.00
SK 0.00
CaK 5.67
TiK 0.00

OK 33.43 ZAF Elem Wt

Class Filter
Min 0.0
Max 100.0

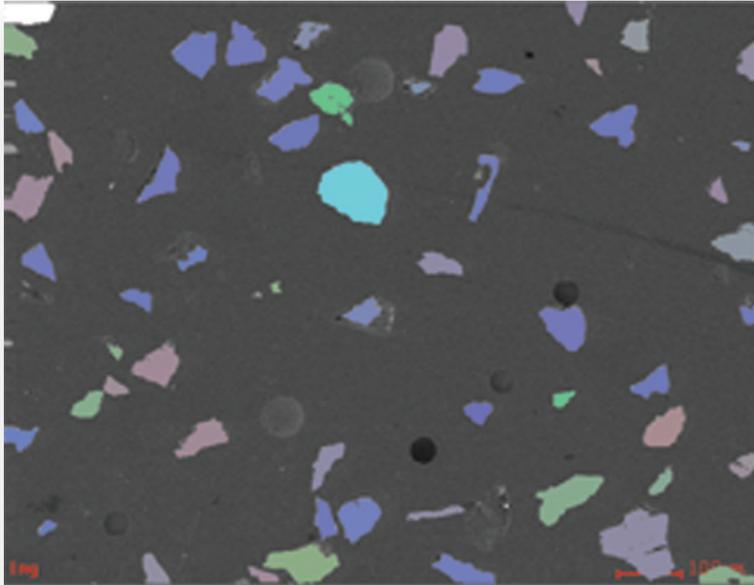
Pre Scal 1.0

Pass Filter
 Min CF 1000



Precipitated minerals in a polished rock are classified and color-coded based on their identified elemental components

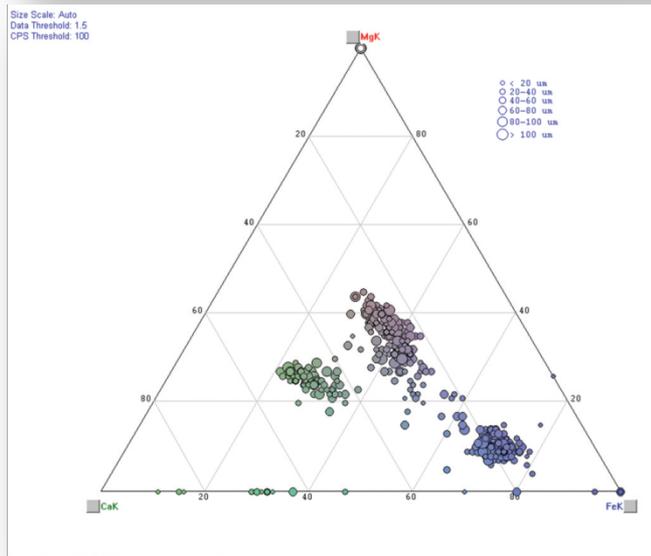
Elemental Analysis



Expands the EDS capability of the SEM

Allows automated analysis of precipitates embedded on a matrix

Makes it easier to obtain physical statistics of particles that require larger field of view



Ternary diagram showing the distribution of sizes and elemental ratios of the particles

Limitations

Energy resolution: **130 eV**

Spatial resolution: **~1 μm^3**

Limit of Detection

1000 – 3000 ppm (0.1 – 0.3%)

Accuracy: ~95 %

Relative Error: 1% for polished sample with standards

5% for particulates and rough surfaces without standard

major components (>10%) $\pm 5\%$

minor components (1 – 10%) $\pm 5 - 10\%$

trace components (<1 %) $\pm 10 - 20\%$

Not a surface analysis technique!!!

References:

Particles Analysis Software training videos

Expanding EDS Analysis with Advanced Particle, EDAX EDS technical note